Applicant(s)/Patent Under Application/Control No. Reexamination 10/813,410 CHANG ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Yogesh C. Garg 3625 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0133498 A1 07-2004 Yeh et al. 705/037 Α US-В US-С US-D US-Ε F US-US-G US-Н US-US-

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